

<b>Notice of References Cited</b>		Application/Control No. 10/561,923	Applicant(s)/Patent Under Reexamination MAENISHI ET AL.	
		Examiner SHEWANA SKINNER	Art Unit 3689	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2002/0188259	12-2002	Hickle et al.	604/189
*	B US-6,754,485	06-2004	Obradovich et al.	455/414.1
*	C US-6,987,964	01-2006	Obradovich et al.	455/414.1
*	D US-2005/0275515	12-2005	Morris, Steven E.	340/438
*	E US-2002/0174025	11-2002	Hind et al.	705/26
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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V	
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